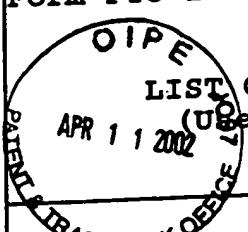


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Patent and Trademark OfficeAtty Dkt. No.
65988 CCDSerial No.
09/966,171

Applicants

K. YAMADA et al.Filing Date
09/28/2001Group
2652LIST OF PRIOR ART CITED BY APPLICANT
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U.S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date if Appropri- ate
<i>MR</i>	AA 3 5 3 0 4 4 1	9/70	Ovshinsky	340	173	
<i>MR</i>	AB 5 1 5 0 3 5 1	9/92	Ohno et al.	369	116	
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FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
<i>AL</i>	AL 4 0 5 2 1 8 9	2/92	Japan			<i>abstract</i>	
<i>AM</i>	AM 4 0 7 8 0 3 1	3/92	Japan			"	
<i>AN</i>	AN 4 1 2 3 5 5 1	4/92	Japan			"	
<i>AO</i>	AO 63 2 6 6 6 3 2	11/88	Japan			"	
<i>AP</i>	AP 63 2 6 6 6 3 3	11/88	Japan			"	

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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Patent and Trademark OfficeAtty Dkt. No.
65988 CCD Serial No.
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K. YAMADA et al.Filing Date
09/28/01 Group
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AL	11 1 1 5 3 1 3	4/99	Japan				Abstract	
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AO	4 2 3 2 7 7 9	8/92	Japan				"	
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65988 CCDSerial No.
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Applicants

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Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate
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AL	5345478	12/93	Japan	—	—	abstract	
AM	6166266	6/94	Japan	—	—	"	
AN	1303643	12/89	Japan	—	—	"	
AO	6166268	6/94	Japan	—	—	"	
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AL	61 2 7 0 1 9 0	11/86	Japan				abstract		
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AN	62 0 7 3 4 3 8	4/87	Japan				"		
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AL	1 2 7 7 3 3 8	11/89	Japan				abstract	
AM	60 1 7 7 4 4 6	9/85	Japan				"	
AN	4 1 6 3 8 3 9	6/92	Japan				"	
AO	4 0 5 2 1 8 8	2/92	Japan				"	
AP	9 1 3 8 9 4 6	5/97	Japan				"	

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Applicants

OK. YAMADA et al.

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AL	9138947	5/97	Japan			abstract	
AM	9219021	8/97	Japan			"	
AN	63029336	6/88	Japan			" *	
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AR	* Patent Abstracts of Japan, abstract of 61-239428 A published 10/24/86 (abstract of Japan, 63-029336, listed above)
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K. YAMADA et al.Filing Date
09/28/2001 Group
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ar	AA S 7 3 6 6 5 7	4/98	Ide et al.	75	230	RECEIVED
gr	AB S 7 8 5 8 2 8	7/98	Yamada et al.	204	298.13	Center
ar	AC S 9 4 8 4 9 6	9/99	Kinoshita et al.	428	64.1	2002
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ar	AH 6 2 2 1 5 5 7	4/01	Harigaya et al.	430	270.13	2/27/97
ar	AI 6 2 8 0 6 8 4	8/01	Yamada et al.	419	54	12/12/95
ar	AJ 6 3 1 9 3 6 8	11/01	Ide et al.	204	192.26	3/26/96
ar	AK 6 3 9 1 4 1 7	5/02	Yuzurihara et al.	428	64.1	11/25/98

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	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
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ar	AR	K. Furuya et al., "Disk structure and composition of Ge-Te-Sb recording film..." Lecture draft, 4th phase change recording study symposium, 1992 (with abstract)
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Filing Date 09/28/2001 Group 26521-196

OCT 21 2001 JCJ

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AA	09 8 2 1 2 0 4	—	claims, abstract, drawings			3/29/2001
AB	09 6 6 5 4 7 3	—	claims, abstract, drawings			9/20/2000
AC	09 6 7 0 2 2 0	—	claims, abstract, drawings			9/25/2000
AD	09 5 8 5 3 8 0	—	claims, abstract, drawings			6/1/2000
AE	09 5 6 9 5 0 1	—	claims, abstract, drawings			5/11/2000
AF	09 5 3 4 1 8 3	—	claims, abstract, drawings			3/24/2000
AG	09 5 6 8 7 2 3	—	claims, abstract, drawings			5/11/2000
AH	09 4 7 1 3 4 5	—	claims, abstract, drawings			12/23/1999
AI	09 5 3 9 8 6 5	—	claims, abstract, drawings			3/31/2000
AJ	09 2 3 6 4 4 6	—	claims, abstract, drawings			1/25/1999
AK	09 7 9 5 6 3 7	—	claims, abstract, drawings			2/28/2001

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UR	AR	T. Handa et al., "In-Ag-Te-Sb Phase Change Recording Media...," Jpn. J. Appl. Phys. 32:5226-5229 (1993)
UR	AS	S. Maita et al., "Erasable Phase Change Optical Disks for Recording at Low...," Lecture draft, 5 th phase change recording study symposium, 1993 (with abstract)
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Atty Dkt. No.
65988 CCDSerial No.
09/966,171

Applicants

K. YAMADA et al.Filing Date
09/28/2001Group
2652 172

U.S. PATENT DOCUMENTS

Examiner Initial	Document Number <small>TRADEMARK</small>	Date	Name	Class	Subclass	Filing Date if Appropriate	Technology Center 2600
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FOREIGN PATENT DOCUMENTS

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OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

UR	AR	H. Iwasaki et al., "Completely Erasable Phase Change Optical Disk," Jpn. J. Appl. Phys. 31: 461-465 (1992)
UR	AS	Y. Ide et al., "Completely Erasable Phase Change Optical Disk," Lecture draft, 3rd phase change recording study symposium, 1991 (with abstract)
UR	AT	H. Iwasaki et al., "Completely Erasable Phase Change Optical Disc II : ...," Jpn. J. Appl. Phys. 32: 5241-5247 (1993)

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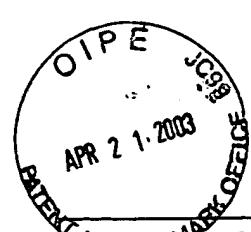
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Patent and Trademark OfficeAtty Dkt. No. **65988 CCD** Serial No. **09/966,171**LIST OF PRIOR ART CITED BY APPLICANT
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K. YAMADA et al.Filing Date **09/28/2001** Group **2652**

U. S. PATENT DOCUMENTS

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	Document Number	Date	Country	Class	Subclass	Translation	
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AN							
AO							
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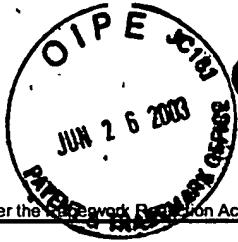
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4/12/04

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Application Number: 62-1065

Application Number	09/966,171
Filing Date	09/28/2001
First Named Inventor	K. YAMADA
Art Unit	
Examiner Name	
Attorney Docket Number	65988 CCD

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Examiner Initials*	Cite No. ¹	Foreign Patent Document Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages Or Relevant Figures Appear	
					T ⁶	
BR		EP 0 735 158 A	10-02-1996	Ricoh KK		
Y		EP 0 828 245 A	03-11-1998	Ricoh KK		
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BR		EP 1 280 142 A	01-29-2003	Ricoh KK		

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